

Search Notes

Application/Control No.

10/565,434

Examiner

B. Dell Chism

Applicant(s)/Patent under
Reexamination

SATORU FURUKAWA

Art Unit

1654

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB text search	See interference search printout	3-4-07	BDC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST (514/18: text) STN (Caplus, Biosis, Scisearch, Medline) Inventor Search	3-4-07	BDC